Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | FENG ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,334,854	08-1994	Ono et al.	257/13
	В	US-4,845,535	07-1989	Yamanishi et al.	315/172
	С	US-2002/0030195	03-2002	Yoshii et al.	257/101
	D	US-5,239,550	08-1993	Jain, Faquir C.	372/45
	E	US-5,293,050	03-1994	Chapple-Sokol et al.	257/17
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	K.	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N			·	·	
	0					
	P					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	8	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.